30	Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/075,218	KOBAYASHI ET AL.	
Examiner	Art Unit	
Steven J. Fulk	2891	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	<b>)</b>
	DATE	EXMR
Updated EAST Search	12/21/2007	SJF
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